

**Notice of References Cited**

Application/Control No.

09/675,165

Applicant(s)/Patent Under  
Reexamination  
OTSUKA ET AL.

Examiner

Thinh H Nguyen

Art Unit

2861

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**U.S. PATENT DOCUMENTS**

*		Document Number		Date MM-YYYY	Name	Classification	
		Country Code	Number-Kind Code				
	A	US-	-				
	B	US-	-				
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**FOREIGN PATENT DOCUMENTS**

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		Country Code	Number-Kind Code					
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	P	-	-					
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